

WARP2 SERIES IGBT WITH
ULTRAFAST SOFT RECOVERY DIODE

Applications

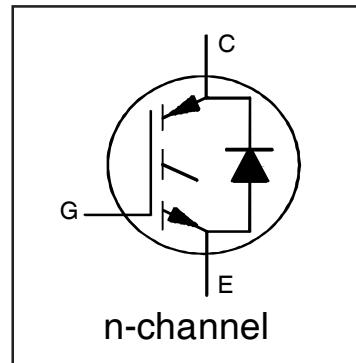
- Telecom and Server SMPS
- PFC and ZVS SMPS Circuits
- Uninterruptable Power Supplies
- Consumer Electronics Power Supplies
- Lead-Free

Features

- NPT Technology, Positive Temperature Coefficient
- Lower $V_{CE}(\text{SAT})$
- Lower Parasitic Capacitances
- Minimal Tail Current
- HEXFRED Ultra Fast Soft-Recovery Co-Pack Diode
- Tighter Distribution of Parameters
- Higher Reliability

Benefits

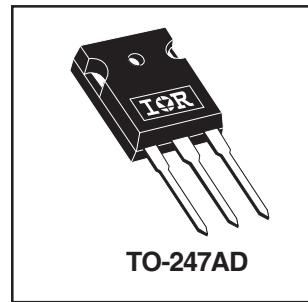
- Parallel Operation for Higher Current Applications
- Lower Conduction Losses and Switching Losses
- Higher Switching Frequency up to 150KHz



$V_{CES} = 600V$
 $V_{CE(\text{on})}$ typ. = 1.85V
@ $V_{GE} = 15V$ $I_C = 22A$

**Equivalent MOSFET
Parameters^①**

$R_{CE(\text{on})}$ typ. = 84mΩ
 I_D (FET equivalent) = 35A

**Absolute Maximum Ratings**

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ\text{C}$	Continuous Collector Current	60	
$I_C @ T_C = 100^\circ\text{C}$	Continuous Collector Current	34	
I_{CM}	Pulse Collector Current (Ref. Fig. C.T.4)	120	
I_{LM}	Clamped Inductive Load Current ②	120	
$I_F @ T_C = 25^\circ\text{C}$	Diode Continuous Forward Current	40	
$I_F @ T_C = 100^\circ\text{C}$	Diode Continuous Forward Current	15	
I_{FRM}	Maximum Repetitive Forward Current ③	60	A
V_{GE}	Gate-to-Emitter Voltage	±20	
$P_D @ T_C = 25^\circ\text{C}$	Maximum Power Dissipation	308	
$P_D @ T_C = 100^\circ\text{C}$	Maximum Power Dissipation	123	
T_J	Operating Junction and	-55 to +150	
T_{STG}	Storage Temperature Range	°C	
	Soldering Temperature for 10 sec.		300 (0.063 in. (1.6mm) from case)
	Mounting Torque, 6-32 or M3 Screw		10 lbf·in (1.1 N·m)

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R_{0JC} (IGBT)	Thermal Resistance Junction-to-Case-(each IGBT)	—	—	0.41	°C/W
R_{0JC} (Diode)	Thermal Resistance Junction-to-Case-(each Diode)	—	—	1.7	
R_{0CS}	Thermal Resistance, Case-to-Sink (flat, greased surface)	—	0.24	—	
R_{0JA}	Thermal Resistance, Junction-to-Ambient (typical socket mount)	—	—	40	
	Weight	—	6.0 (0.21)	—	g (oz)

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions	Ref.Fig
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	600	—	—	V	$V_{GE} = 0V, I_C = 500\mu\text{A}$	
$\Delta V_{(BR)CES}/\Delta T_J$	Temperature Coeff. of Breakdown Voltage	—	0.78	—	V/ $^\circ\text{C}$	$V_{GE} = 0V, I_C = 1\text{mA}$ (25°C - 125°C)	
R_G	Internal Gate Resistance	—	1.7	—	Ω	1MHz, Open Collector	
$V_{CE(on)}$	Collector-to-Emitter Saturation Voltage	—	1.85	2.15	V	$I_C = 22\text{A}, V_{GE} = 15\text{V}$	4, 5, 6, 8, 9
		—	2.25	2.55		$I_C = 35\text{A}, V_{GE} = 15\text{V}$	
		—	2.37	2.80		$I_C = 22\text{A}, V_{GE} = 15\text{V}, T_J = 125^\circ\text{C}$	
		—	3.00	3.45		$I_C = 35\text{A}, V_{GE} = 15\text{V}, T_J = 125^\circ\text{C}$	
$V_{GE(th)}$	Gate Threshold Voltage	3.0	4.0	5.0	V	$I_C = 250\mu\text{A}$	7, 8, 9
$\Delta V_{GE(th)}/\Delta T_J$	Threshold Voltage temp. coefficient	—	-10	—	mV/ $^\circ\text{C}$	$V_{CE} = V_{GE}, I_C = 1.0\text{mA}$	
g_f	Forward Transconductance	—	36	—	S	$V_{CE} = 50\text{V}, I_C = 22\text{A}, PW = 80\mu\text{s}$	
I_{CES}	Collector-to-Emitter Leakage Current	—	3.0	375	μA	$V_{GE} = 0V, V_{CE} = 600\text{V}$	
		—	0.35	—	mA	$V_{GE} = 0V, V_{CE} = 600\text{V}, T_J = 125^\circ\text{C}$	
V_{FM}	Diode Forward Voltage Drop	—	1.30	1.70	V	$I_F = 15\text{A}, V_{GE} = 0\text{V}$	10
		—	1.20	1.60		$I_F = 15\text{A}, V_{GE} = 0\text{V}, T_J = 125^\circ\text{C}$	
I_{GES}	Gate-to-Emitter Leakage Current	—	—	± 100	nA	$V_{GE} = \pm 20\text{V}, V_{CE} = 0\text{V}$	

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions	Ref.Fig	
Q_g	Total Gate Charge (turn-on)	—	160	240	nC	$I_C = 22\text{A}$	17 CT1	
Q_{gc}	Gate-to-Collector Charge (turn-on)	—	55	83		$V_{CC} = 400\text{V}$		
Q_{ge}	Gate-to-Emitter Charge (turn-on)	—	21	32		$V_{GE} = 15\text{V}$		
E_{on}	Turn-On Switching Loss	—	220	270	μJ	$I_C = 22\text{A}, V_{CC} = 390\text{V}$	CT3	
E_{off}	Turn-Off Switching Loss	—	215	265		$V_{GE} = +15\text{V}, R_G = 3.3\Omega, L = 200\mu\text{H}$		
E_{total}	Total Switching Loss	—	435	535		$T_J = 25^\circ\text{C}$ ④		
$t_{d(on)}$	Turn-On delay time	—	26	34	ns	$I_C = 22\text{A}, V_{CC} = 390\text{V}$	CT3	
t_r	Rise time	—	6.0	8.0		$V_{GE} = +15\text{V}, R_G = 3.3\Omega, L = 200\mu\text{H}$		
$t_{d(off)}$	Turn-Off delay time	—	110	122		$T_J = 25^\circ\text{C}$ ④		
t_f	Fall time	—	8.0	10	μJ	$I_C = 22\text{A}, V_{CC} = 390\text{V}$	CT3 11, 13 WF1, WF2	
E_{on}	Turn-On Switching Loss	—	410	465		$V_{GE} = +15\text{V}, R_G = 3.3\Omega, L = 200\mu\text{H}$		
E_{off}	Turn-Off Switching Loss	—	330	405		$T_J = 125^\circ\text{C}$ ④		
E_{total}	Total Switching Loss	—	740	870	ns	$I_C = 22\text{A}, V_{CC} = 390\text{V}$	CT3 12, 14 WF1, WF2	
$t_{d(on)}$	Turn-On delay time	—	26	34		$V_{GE} = +15\text{V}, R_G = 3.3\Omega, L = 200\mu\text{H}$		
t_r	Rise time	—	8.0	11		$T_J = 125^\circ\text{C}$ ④		
$t_{d(off)}$	Turn-Off delay time	—	130	150	pF	$I_C = 22\text{A}, V_{CC} = 390\text{V}$	16	
t_f	Fall time	—	12	16		$V_{CC} = 30\text{V}$		
C_{ies}	Input Capacitance	—	3715	—		$f = 1\text{Mhz}$		
C_{oes}	Output Capacitance	—	265	—	$V_{GE} = 0V, V_{CE} = 0\text{V to } 480\text{V}$	$V_{GE} = 0V$	15	
C_{res}	Reverse Transfer Capacitance	—	47	—		$V_{CC} = 30\text{V}$		
$C_{oes\ eff.}$	Effective Output Capacitance (Time Related) ⑤	—	135	—		$f = 1\text{Mhz}$		
$C_{oes\ eff.\ (ER)}$	Effective Output Capacitance (Energy Related) ⑤	—	179	—	A	$V_{GE} = 0V, V_{CE} = 0\text{V to } 480\text{V}$	3 CT2 21 CT5	
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE				$T_J = 150^\circ\text{C}, I_C = 120\text{A}$		
						$V_{CC} = 480\text{V}, V_p = 600\text{V}$		
						$R_g = 22\Omega, V_{GE} = +15\text{V to } 0\text{V}$		
t_{rr}	Diode Reverse Recovery Time	—	42	60	ns	$T_J = 25^\circ\text{C}$ $I_F = 15\text{A}, V_R = 200\text{V}$	19	
		—	74	120		$T_J = 125^\circ\text{C}$ $di/dt = 200\text{A}/\mu\text{s}$		
Q_{rr}	Diode Reverse Recovery Charge	—	80	180	nC	$T_J = 25^\circ\text{C}$ $I_F = 15\text{A}, V_R = 200\text{V}$	21	
		—	220	600		$T_J = 125^\circ\text{C}$ $di/dt = 200\text{A}/\mu\text{s}$		
I_{rr}	Peak Reverse Recovery Current	—	4.0	6.0	A	$T_J = 25^\circ\text{C}$ $I_F = 15\text{A}, V_R = 200\text{V}$	19, 20, 21, 22 CT5	
		—	6.5	10		$T_J = 125^\circ\text{C}$ $di/dt = 200\text{A}/\mu\text{s}$		

Notes:

① $R_{CE(on)}$ typ. = equivalent on-resistance = $V_{CE(on)}$ typ./ I_C , where $V_{CE(on)}$ typ.= 1.85V and $I_C = 22\text{A}$. I_D (FET Equivalent) is the equivalent MOSFET I_D rating @ 25°C for applications up to 150kHz. These are provided for comparison purposes (only) with equivalent MOSFET solutions.

② $V_{CC} = 80\%$ (V_{CES}), $V_{GE} = 15\text{V}$, $L = 28\ \mu\text{H}$, $R_G = 22\ \Omega$.

③ Pulse width limited by max. junction temperature.

④ Energy losses include "tail" and diode reverse recovery, Data generated with use of Diode 30ETH06.

⑤ $C_{oes\ eff.}$ is a fixed capacitance that gives the same charging time as C_{oes} while V_{CE} is rising from 0 to 80% V_{CES} .

$C_{oes\ eff.(ER)}$ is a fixed capacitance that stores the same energy as C_{oes} while V_{CE} is rising from 0 to 80% V_{CES} .

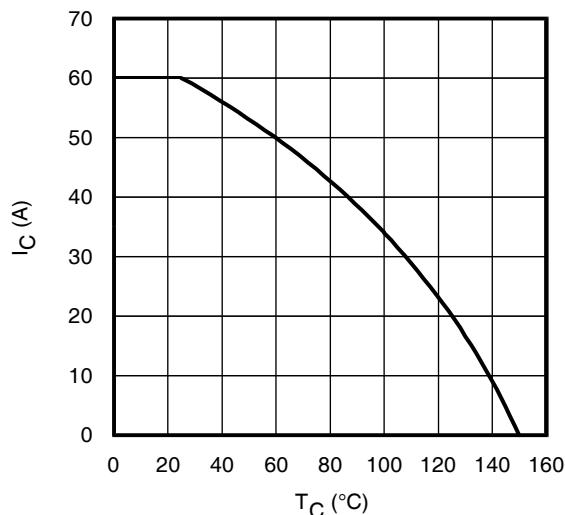


Fig. 1 - Maximum DC Collector Current vs. Case Temperature

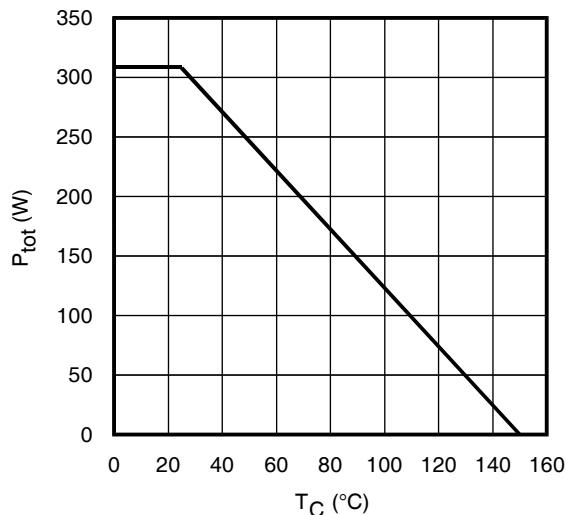


Fig. 2 - Power Dissipation vs. Case Temperature

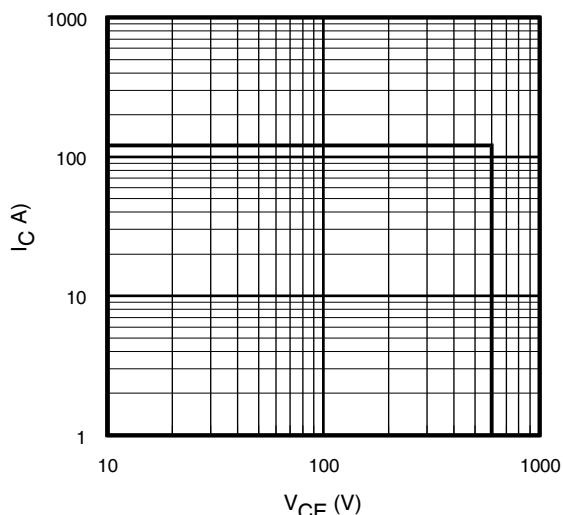


Fig. 3 - Reverse Bias SOA
 $T_J = 150^\circ\text{C}$; $V_{GE} = 15\text{V}$

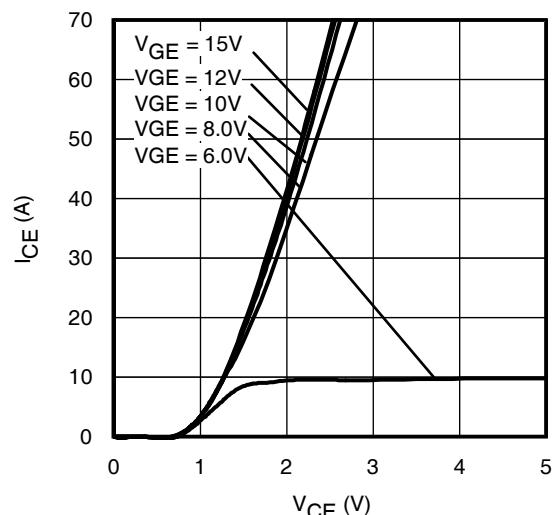


Fig. 4 - Typ. IGBT Output Characteristics
 $T_J = -40^\circ\text{C}$; $t_p = 80\mu\text{s}$

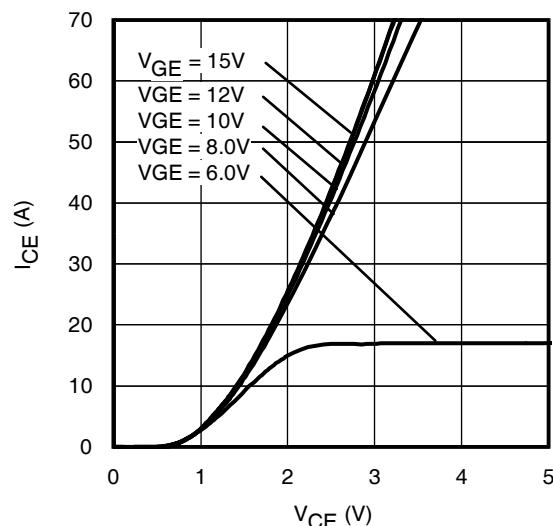


Fig. 5 - Typ. IGBT Output Characteristics
 $T_J = 25^\circ\text{C}$; $t_p = 80\mu\text{s}$

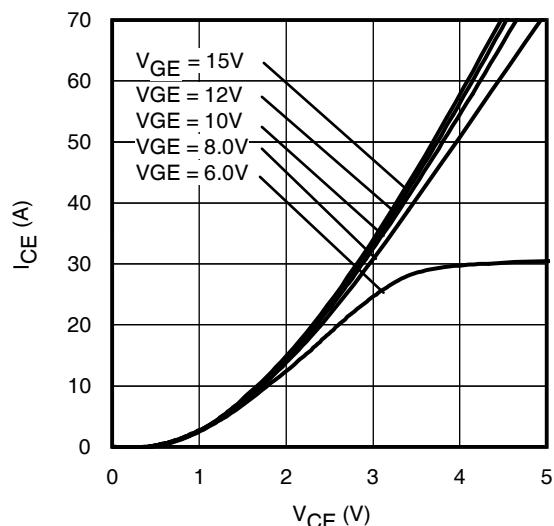


Fig. 6 - Typ. IGBT Output Characteristics
 $T_J = 125^\circ\text{C}$; $t_p = 80\mu\text{s}$

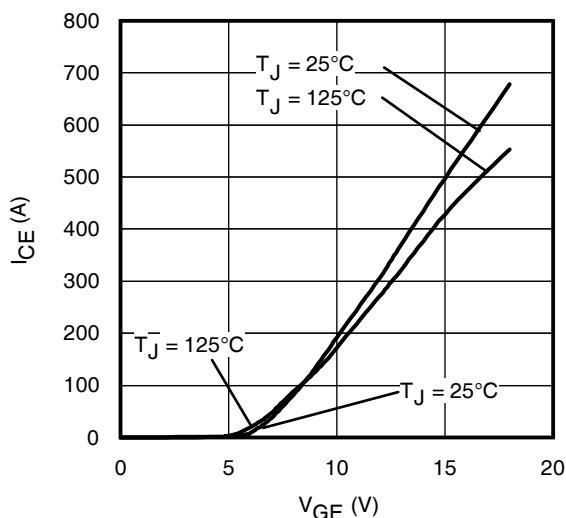


Fig. 7 - Typ. Transfer Characteristics
 $V_{CE} = 50\text{V}$; $t_p = 10\mu\text{s}$

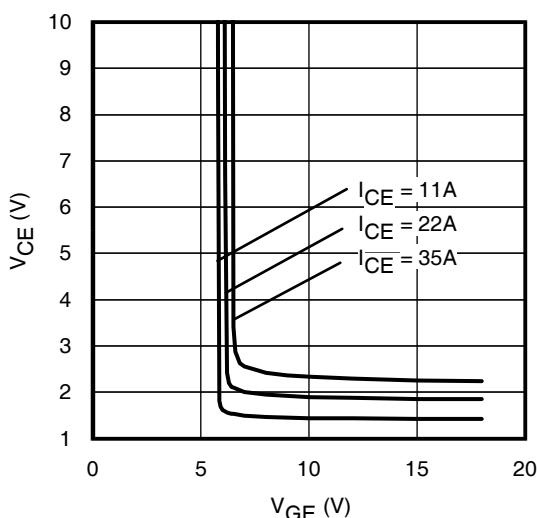


Fig. 8 - Typical V_{CE} vs. V_{GE}
 $T_J = 25^\circ\text{C}$

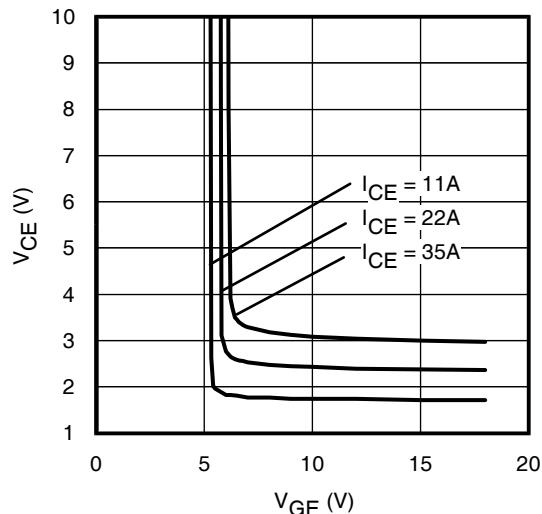


Fig. 9 - Typical V_{CE} vs. V_{GE}
 $T_J = 125^\circ\text{C}$

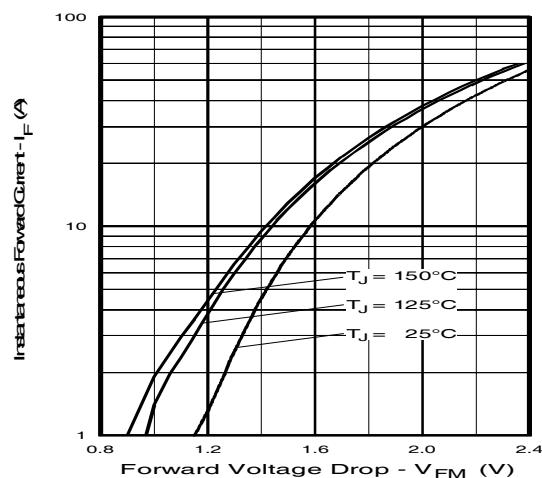


Fig. 10 - Typ. Diode Forward Characteristics
 $t_p = 80\mu\text{s}$

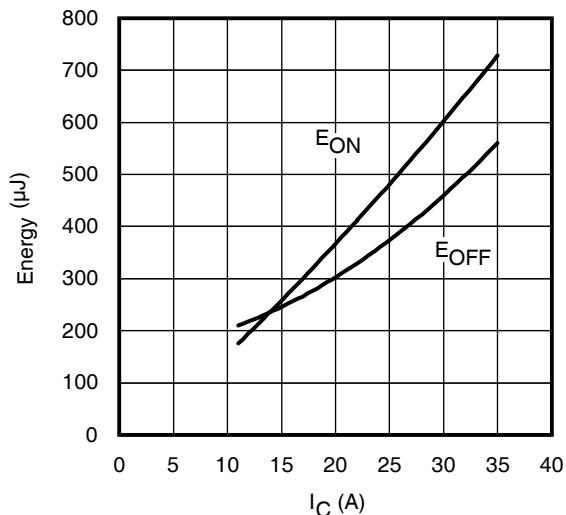


Fig. 11 - Typ. Energy Loss vs. I_C
 $T_J = 125^\circ\text{C}$; $L = 200\mu\text{H}$; $V_{CE} = 390\text{V}$, $R_G = 3.3\Omega$; $V_{GE} = 15\text{V}$.
Diode clamp used: 30ETH06 (See C.T.3)

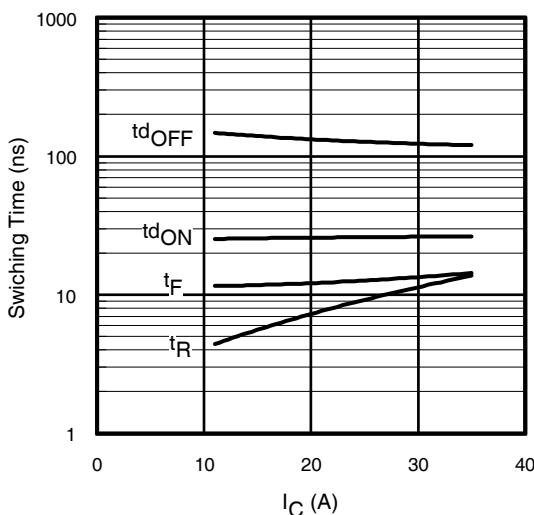


Fig. 12 - Typ. Switching Time vs. I_C
 $T_J = 125^\circ\text{C}$; $L = 200\mu\text{H}$; $V_{CE} = 390\text{V}$, $R_G = 3.3\Omega$; $V_{GE} = 15\text{V}$.
Diode clamp used: 30ETH06 (See C.T.3)

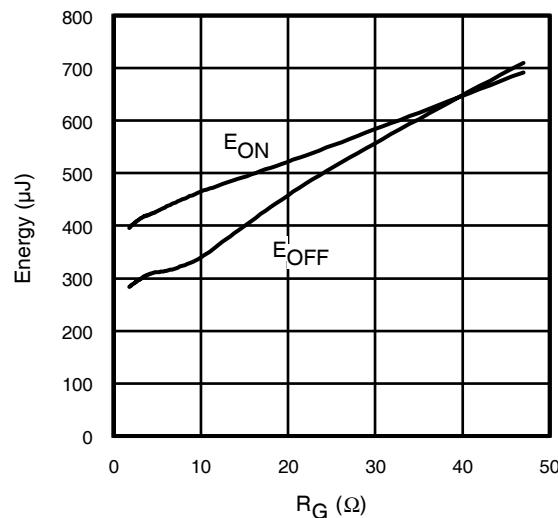


Fig. 13 - Typ. Energy Loss vs. R_G
 $T_J = 125^\circ\text{C}$; $L = 200\mu\text{H}$; $V_{CE} = 390\text{V}$, $I_{CE} = 22\text{A}$; $V_{GE} = 15\text{V}$
 Diode clamp used: 30ETH06 (See C.T.3)

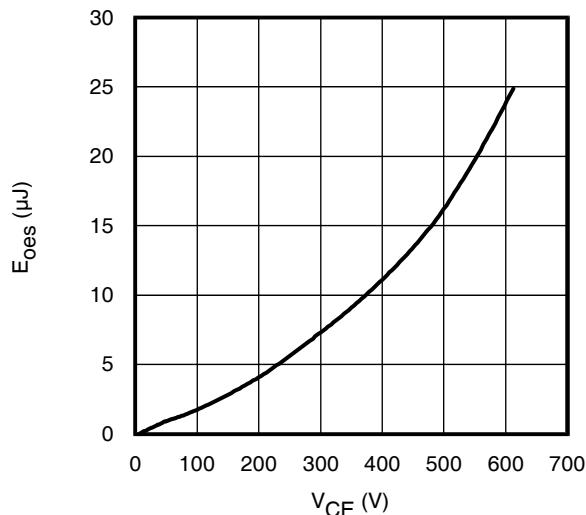


Fig. 15- Typ. Output Capacitance Stored Energy vs. V_{CE}

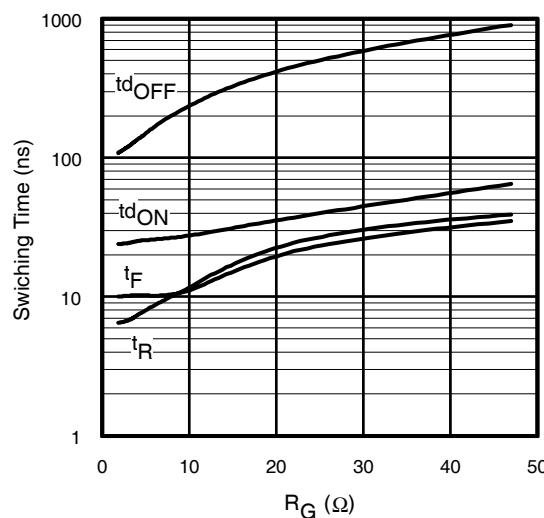


Fig. 14 - Typ. Switching Time vs. R_G
 $T_J = 125^\circ\text{C}$; $L = 200\mu\text{H}$; $V_{CE} = 390\text{V}$, $I_{CE} = 22\text{A}$; $V_{GE} = 15\text{V}$
 Diode clamp used: 30ETH06 (See C.T.3)

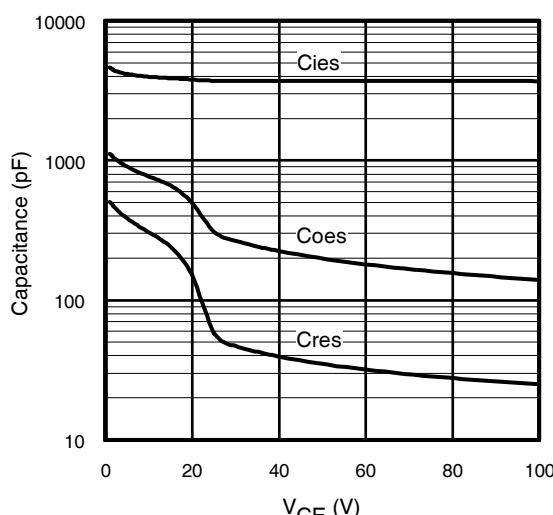


Fig. 16- Typ. Capacitance vs. V_{CE}
 $V_{GE} = 0\text{V}$; $f = 1\text{MHz}$

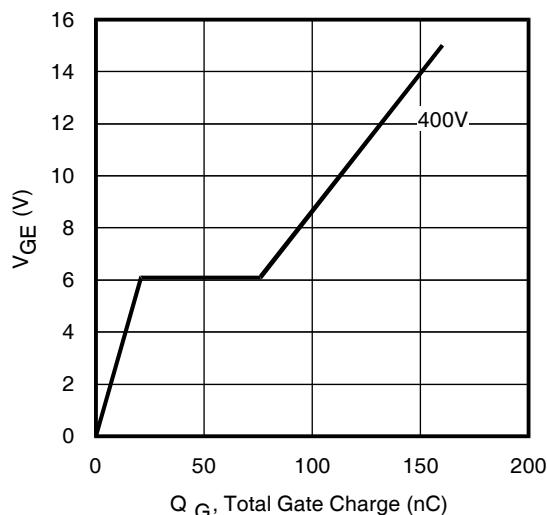


Fig. 17 - Typical Gate Charge vs. V_{GE}
 $I_{CE} = 22\text{A}$

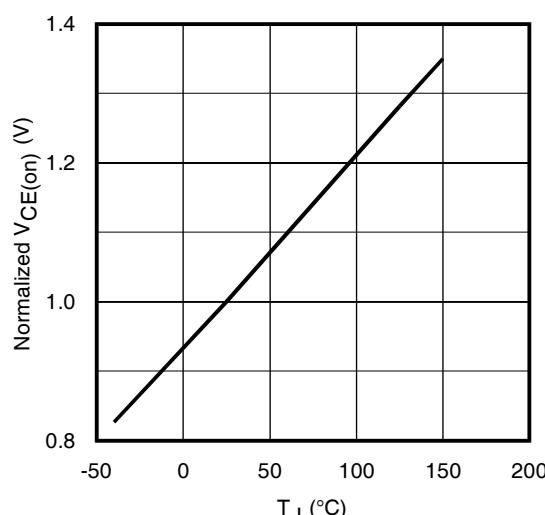


Fig. 18 - Normalized Typ. $V_{CE(on)}$ vs. Junction Temperature
 $I_C = 22\text{A}$, $V_{GE} = 15\text{V}$

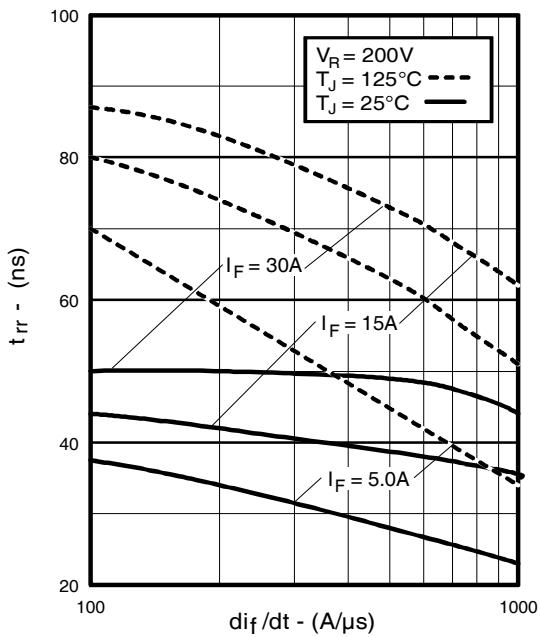


Fig. 19 - Typical Reverse Recovery vs. di_f/dt

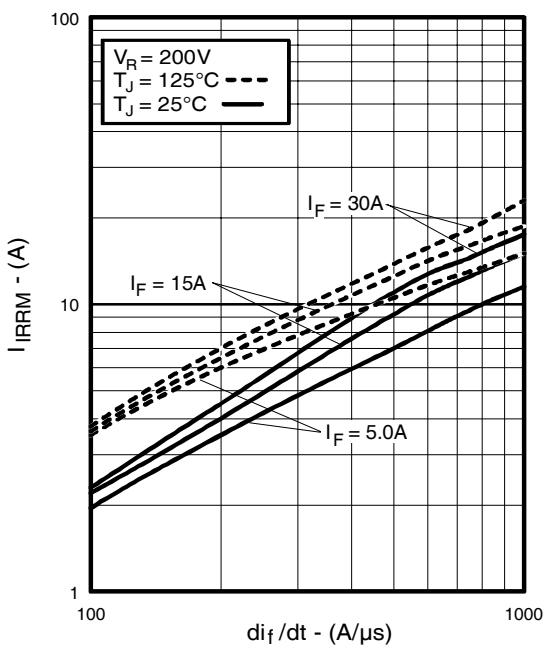


Fig. 20 - Typical Recovery Current vs. di_f/dt

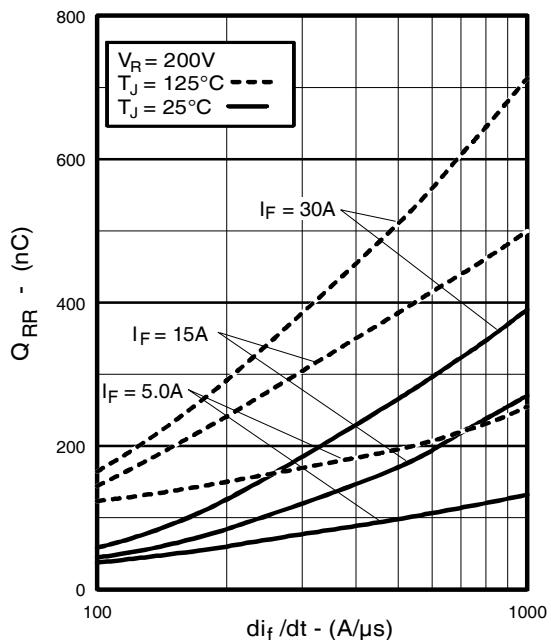


Fig. 21 - Typical Stored Charge vs. di_f/dt

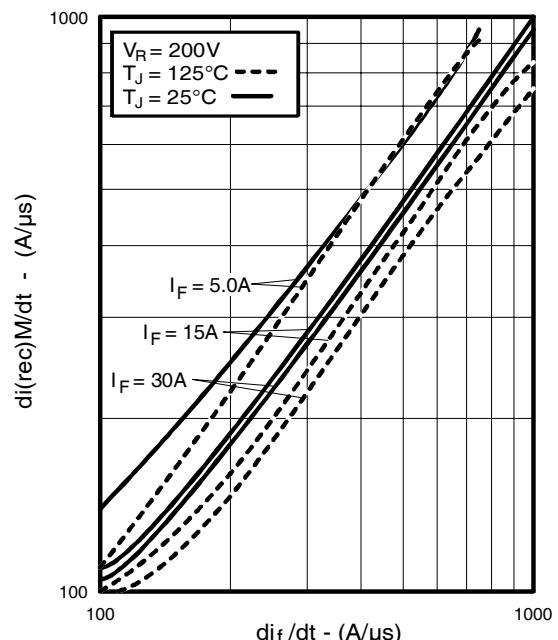


Fig. 22 - Typical $di_{(rec)}M/dt$ vs. di_f/dt ,

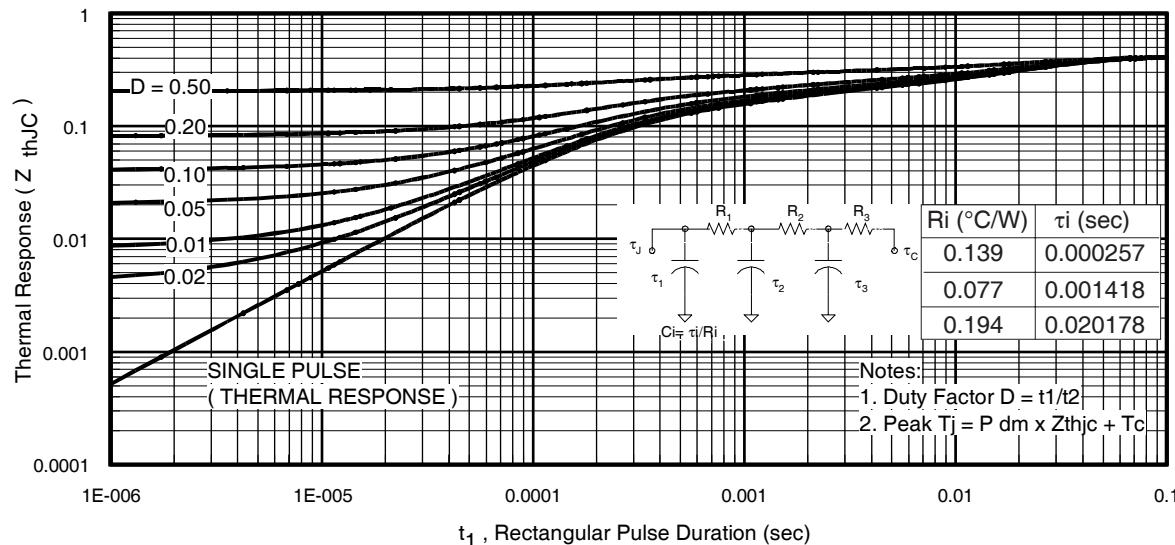


Fig 23. Maximum Transient Thermal Impedance, Junction-to-Case (IGBT)

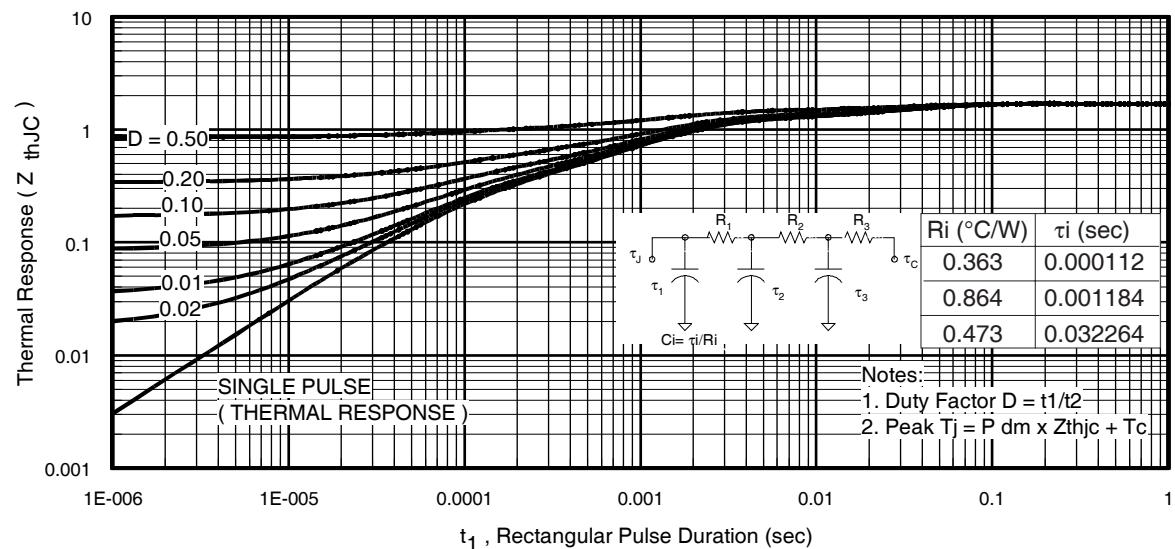


Fig. 24. Maximum Transient Thermal Impedance, Junction-to-Case (DIODE)

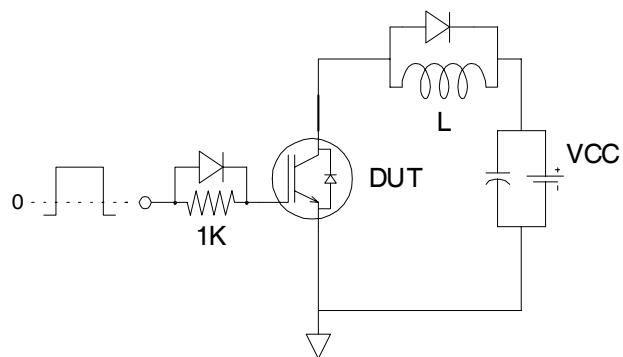


Fig.C.T.1 - Gate Charge Circuit (turn-off)

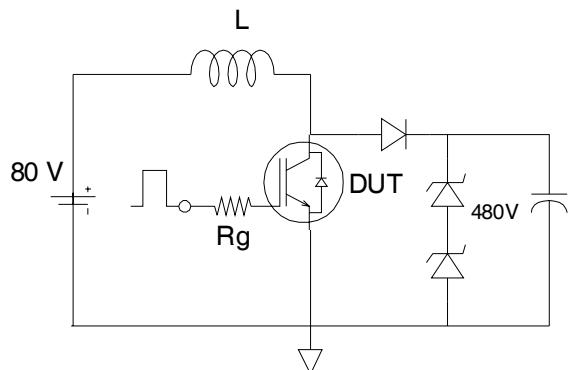


Fig.C.T.2 - RBSOA Circuit

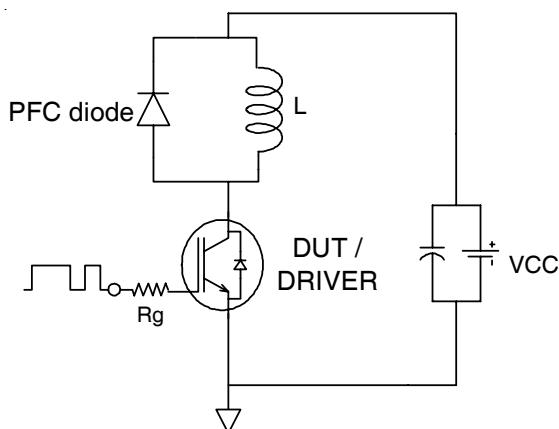


Fig.C.T.3 - Switching Loss Circuit

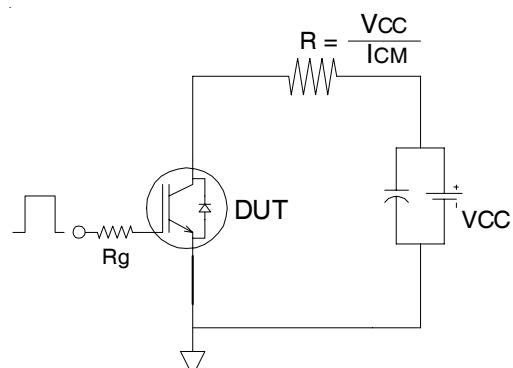


Fig.C.T.4 - Resistive Load Circuit

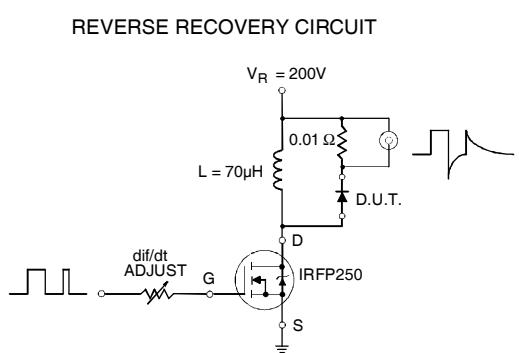


Fig. C.T.5 - Reverse Recovery Parameter Test Circuit

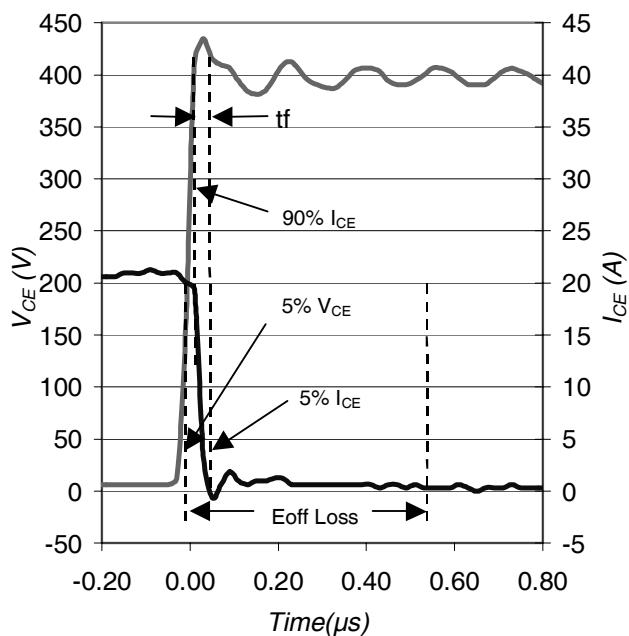


Fig. WF1 - Typ. Turn-off Loss Waveform
@ $T_J = 25^\circ\text{C}$ using Fig. CT.3

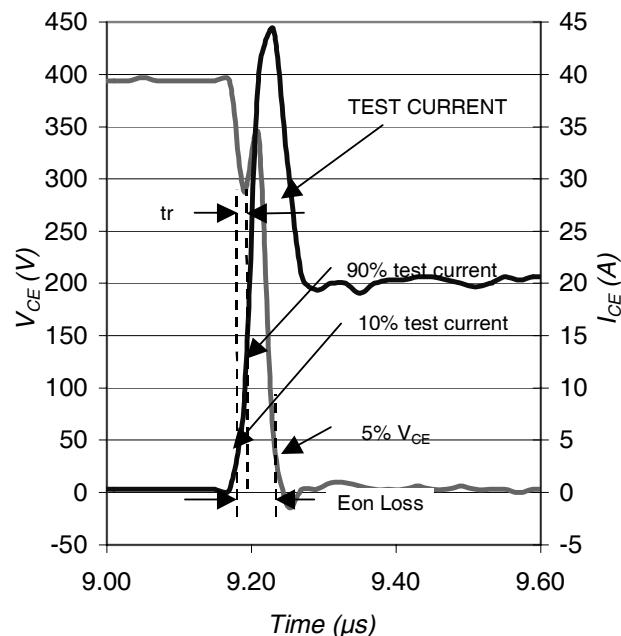
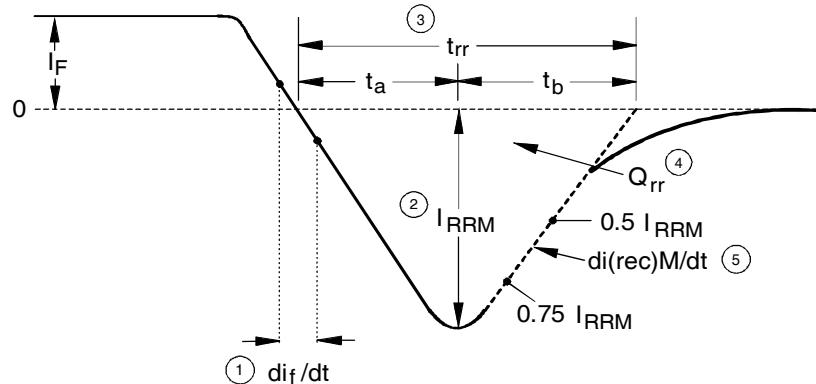


Fig. WF2 - Typ. Turn-on Loss Waveform
@ $T_J = 25^\circ\text{C}$ using Fig. CT.3



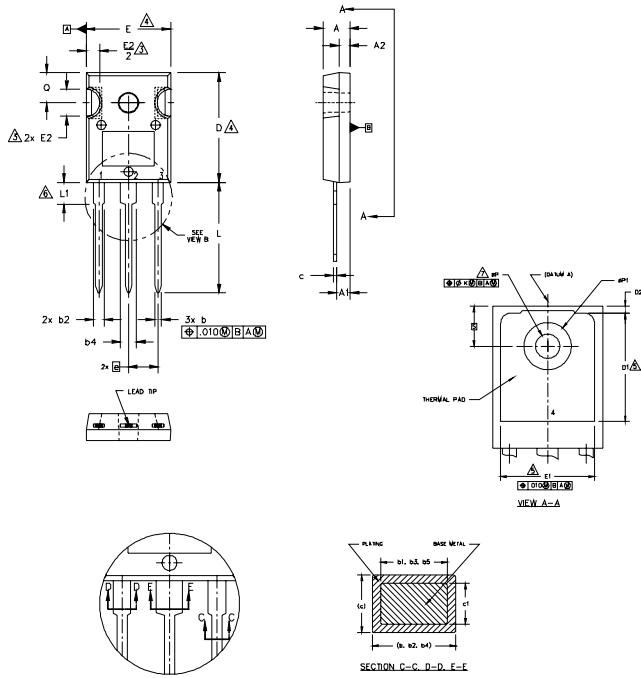
1. di_f/dt - Rate of change of current through zero crossing
2. I_{RRM} - Peak reverse recovery current
3. t_{rr} - Reverse recovery time measured from zero crossing point of negative going I_F to point where a line passing through $0.75 I_{RRM}$ and $0.50 I_{RRM}$ extrapolated to zero current
4. Q_{rr} - Area under curve defined by t_{rr} and I_{RRM}

$$Q_{rr} = \frac{t_{rr} \times I_{RRM}}{2}$$
5. $di_{(rec)}M/dt$ - Peak rate of change of current during t_b portion of t_{rr}

Fig. WF3 - Reverse Recovery Waveform and Definitions

TO-247AD Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
2. DIMENSIONS ARE SHOWN IN INCHES.
3. CONTOUR OF SLOT OPTIONAL.
4. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
5. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
6. LEAD FINISH UNCONTROLLED IN L1.
7. ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AD.

SYMBOL	DIMENSIONS			NOTES	
	INCHES		MILLIMETERS		
	MIN.	MAX.	MIN.	MAX.	
A	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
c	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	—	13.08	—	5
D2	.020	.053	0.51	1.35	
E	.602	.625	15.29	15.87	4
E1	.530	—	13.46	—	
E2	.178	.216	4.52	5.49	
e	.215 BSC		5.46 BSC		
Øk	.010		0.25		
L	.780	.827	19.57	21.00	
L1	.146	.169	3.71	4.29	
ØP	.140	.144	3.56	3.66	
ØP1	—	.291	—	7.39	
Q	.209	.224	5.31	5.69	
S	.217 BSC		5.51 BSC		

LEAD ASSIGNMENTSHEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter
- 4.- COLLECTOR

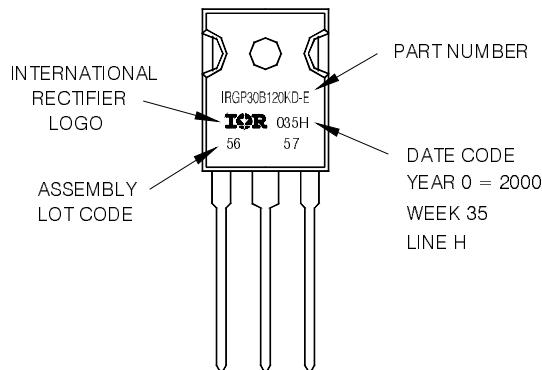
DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

TO-247AD Part Marking Information

EXAMPLE: THIS IS AN IRGP30B120KD-E
WITH ASSEMBLY
LOT CODE 5657
ASSEMBLED ON WW 35, 2000
IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position
indicates "Lead-Free"



TO-247AD package is not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.
This product has been designed and qualified for Industrial market.
Qualification Standards can be found on IR's Web site.

International
IR Rectifier

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